

<b>Notice of References Cited</b>	Application/Control No. 10/786,475		Applicant(s)/Patent Under Reexamination KONVICKA, KAREL	
	Examiner Russell S. Negin		Art Unit 1631	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0017487	01-2003	Xue et al.	435/6
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Krishna et al. Genetic K-Means Algorithm. IEEE Transaction on Systems, Man and Cybernetics-- Part B: Cybernetics, volume 29, June 1999, pages 433-439.
	V	Frey et al. A statistically defines endpoint titer determiantion method for immunoassays. Journal of Immunological Methods. Volume 221, 1998, pages 35-41.
	W	Babu et al. A near-optimal initial seed value selection in K-means algorithm using a genetic algorithm. Pattern Recognition Letters. Volume 14, 1993, pages 763-769/
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.